



AO4444

N-Channel Enhancement Mode Field Effect Transistor

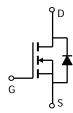
General Description

The AO4444 uses advanced trench technology to provide excellent R_{DS(ON)}, body diode characteristics and ultra-low gate resistance. This device is ideally suited for use as a low side switch in 12V buck converters. Standard Product AO4444 is Pb-free (meets ROHS & Sony 259 specifications). AO4444L is a Green Product ordering option. AO4444 and AO4444L are electrically identical.

Features

$$\begin{split} &V_{DS}\left(V\right) = 30V \\ &I_{D} = 20A \; \left(V_{GS} = 10V\right) \\ &R_{DS(ON)} < 5.5 m\Omega \; (V_{GS} = 10V) \\ &R_{DS(ON)} < 7.5 m\Omega \; (V_{GS} = 4.5V) \end{split}$$





Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V_{DS}	30	V				
Gate-Source Voltage		V_{GS}	±20	V				
Continuous Drain	T _A =25°C		20					
Current ^A	T _A =70°C	I _D	17	A				
Pulsed Drain Current ^B		I _{DM}	80					
	T _A =25°C	В	3	\\\				
Power Dissipation	T _A =70°C	$-P_{D}$	2.1	W				
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C				

Thermal Characteristics								
Parameter	Symbol	Тур	Typ Max					
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\scriptscriptstyle{ hetaJA}}$	31	40	°C/W			
Maximum Junction-to-Ambient ^A	Steady-State	Γ _θ JA	59	75	°C/W			
Maximum Junction-to-Lead ^C Steady-St		$R_{\theta JL}$	16	24	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Parameter Conditions		Min	Тур	Max	Units			
STATIC PARAMETERS										
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$		30			V			
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =24V, V_{GS} =0V				1	μА			
.033	Zoro Gato Foliago Diam Garroni		T _J =55°C			5	μΛ			
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		1	1.8	3	V			
$I_{D(ON)}$	On state drain current	V _{GS} =10V, V _{DS} =5V		60			Α			
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =20A			3.9	5.5	mΩ			
			T _J =125°C		5.1	6.2	11122			
		V _{GS} =4.5V, I _D =15A			5.1	7.5	mΩ			
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =20A			106		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.72	1	V			
I_S	Maximum Body-Diode Continuous Current					4	Α			
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			3200	3840	pF			
Coss	Output Capacitance				590		pF			
C _{rss}	Reverse Transfer Capacitance				414		pF			
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			0.54	0.7	Ω			
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge	-V _{GS} =4.5V, V _{DS} =15V, I _D =20A			63	76	nC			
Q _g (4.5V)	Total Gate Charge				33	40	nC			
Q_{gs}	Gate Source Charge				8.6		nC			
Q_{gd}	Gate Drain Charge				17.6		nC			
t _{D(on)}	Turn-On DelayTime				12		ns			
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =0.75 Ω , R_{GEN} =3 Ω			15.5		ns			
t _{D(off)}	Turn-Off DelayTime				40		ns			
t _f	Turn-Off Fall Time				14		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=100A/μ	S		34	41	ns			
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=100A/μ	.s		30		nC			

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.

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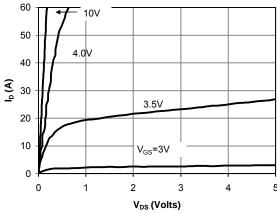
B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using $80\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



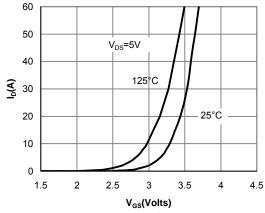
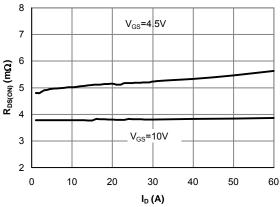




Figure 2: Transfer Characteristics



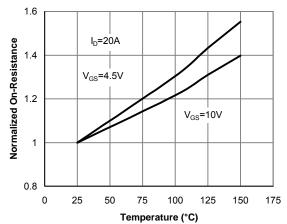
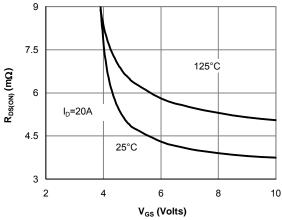


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature



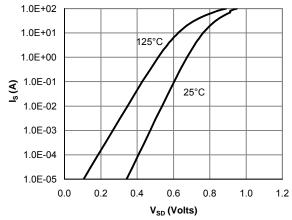


Figure 5: On-Resistance vs. Gate-Source Voltage

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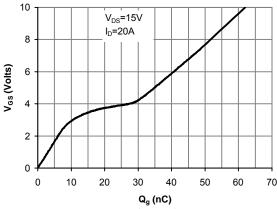


Figure 7: Gate-Charge Characteristics

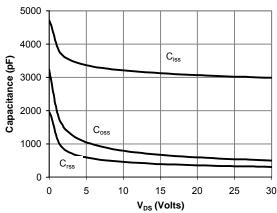


Figure 8: Capacitance Characteristics

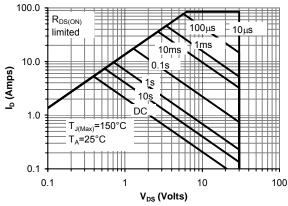


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

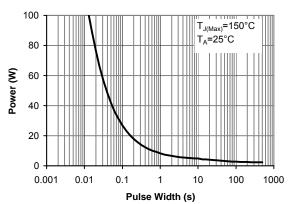


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

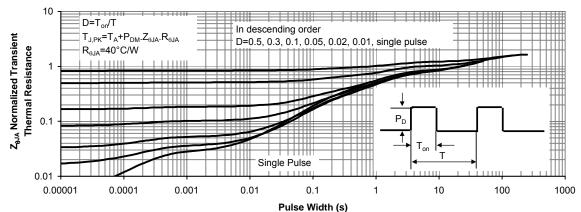


Figure 11: Normalized Maximum Transient Thermal Impedance